

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/080,944 BUCKMAN ET AL.	
		Examiner	Art Unit	Page 1 of 6 Agustin Bello

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,573,433 A	04-1971	Harris, Thomas J.	365/127
*	B	US-3,633,035 A	01-1972	Uchida et al.	398/101
*	C	US-3,785,736 A	01-1974	Spitz et al.	356/71
*	D	US-4,052,706 A	10-1977	Spitz et al.	365/235
*	E	US-4,549,313 A	10-1985	Rozenwaig, Boris	398/57
*	F	US-4,641,273 A	02-1987	Casasent, David	708/816
*	G	US-4,651,297 A	03-1987	Schlunt, Richard S.	708/816
*	H	US-4,705,344 A	11-1987	Hinton et al.	359/15
*	I	US-4,939,630 A	07-1990	Kikuchi et al.	362/268
*	J	US-5,078,499 A	01-1992	LaMarche, Robert E.	359/19
*	K	US-5,081,637 A	01-1992	Fan et al.	372/72
*	L	US-5,093,879 A	03-1992	Bregman et al.	385/93
*	M	US-5,243,619 A	09-1993	Albers et al.	372/97

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/080,944	BUCKMAN ET AL.	
	Examiner Agustin Bello	Art Unit 2613	Page 2 of 6

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,291,324 A	03-1994	Hinterlong, Stephen J.	398/54
*	B	US-5,513,201 A	04-1996	Yamaguchi et al.	372/75
*	C	US-5,546,209 A	08-1996	Willner et al.	398/43
*	D	US-5,557,693 A	09-1996	Stevens et al.	385/24
*	E	US-5,650,612 A	07-1997	Criswell et al.	250/226
*	F	US-5,781,671 A	07-1998	Li et al.	385/17
*	G	US-5,787,107 A	07-1998	Leger et al.	372/71
*	H	US-5,793,906 A	08-1998	Huang, Alan	385/17
*	I	US-5,857,042 A	01-1999	Robertson et al.	385/33
*	J	US-5,920,664 A	07-1999	Hirabayashi et al.	385/16
*	K	US-5,969,872 A	10-1999	Ben Oren et al.	359/621
*	L	US-5,986,788 A	11-1999	Sasaki et al.	398/118
*	M	US-6,005,717 A	12-1999	Neuberger et al.	359/619

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/080,944	BUCKMAN ET AL.	
	Examiner Agustin Bello	Art Unit 2613	Page 3 of 6

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,044,096 A	03-2000	Wolak et al.	372/36
*	B	US-6,091,537 A	07-2000	Sun et al.	359/248
*	C	US-6,117,193 A	09-2000	Glenn, Thomas P.	29/25.01
*	D	US-6,160,664 A	12-2000	Du et al.	359/628
*	E	US-6,175,452 B1	01-2001	Ullmann et al.	359/641
*	F	US-6,195,485 B1	02-2001	Coldren et al.	385/49
*	G	US-6,215,598 B1	04-2001	Hwu, Ruey Jennifer	359/641
*	H	US-6,253,004 B1	06-2001	Lee et al.	385/31
*	I	US-2001/0043381 A1	11-2001	Green et al.	359/172
*	J	US-6,326,600 B1	12-2001	Christensen et al.	250/201.1
*	K	US-6,353,502 B1	03-2002	Marchant et al.	359/626
*	L	US-6,356,577 B1	03-2002	Miller, Gregory David	372/107
*	M	US-6,367,989 B1	04-2002	Hartman et al.	385/89

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/080,944	BUCKMAN ET AL.	
	Examiner Agustin Bello	Art Unit 2613	Page 4 of 6

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,400,513 B1	06-2002	Southwell, William H.	359/641
*	B	US-6,434,308 B1	08-2002	Trezza, John A.	385/119
*	C	US-6,486,984 B1	11-2002	Baney et al.	398/212
*	D	US-6,493,148 B1	12-2002	Anikitchev, Serguei	359/634
*	E	US-6,509,992 B1	01-2003	Goodwill, Dominic J.	398/131
*	F	US-6,516,011 B1	02-2003	Treusch, Hans-Georg	372/29.01
*	G	US-6,527,456 B1	03-2003	Trezza, John A.	385/89
*	H	US-6,530,700 B2	03-2003	Williams, Richard J.	385/92
*	I	US-6,545,425 B2	04-2003	Victor, Michel N.	315/169.3
*	J	US-6,556,352 B2	04-2003	Wang et al.	359/641
*	K	US-6,574,398 B2	06-2003	Coldren et al.	385/49
*	L	US-6,583,904 B1	06-2003	Mahlab et al.	398/129
*	M	US-6,591,042 B2	07-2003	Tatah, Karim	385/43

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/080,944 BUCKMAN ET AL.	
		Examiner	Art Unit	Page 5 of 6 Agustin Bello

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0147652 A1	08-2003	Green et al.	398/118
*	B	US-6,666,590 B2	12-2003	Brosnan, Stephen J.	385/93
*	C	US-6,683,727 B1	01-2004	Goring et al.	359/639
*	D	US-6,695,493 B2	02-2004	Ciemiewcz, Jon T.	385/89
*	E	US-6,771,686 B1	08-2004	Ullman et al.	372/92
*	F	US-6,775,308 B2	08-2004	Hamster et al.	372/28
*	G	US-6,775,480 B1	08-2004	Goodwill, Dominic John	398/158
*	H	US-2004/0207926 A1	10-2004	Buckman et al.	359/642
*	I	US-6,853,812 B2	02-2005	Mays, Jr., Robert	398/130
*	J	US-6,889,010 B2	05-2005	Trezza, John A.	398/130
*	K	US-6,909,554 B2	06-2005	Liu et al.	359/626
*	L	US-7,116,694 B2	10-2006	Peters et al.	372/50.12
*	M	US-7,155,129 B2	12-2006	Bringans et al.	398/131

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/080,944	BUCKMAN ET AL.	
	Examiner Agustin Bello	Art Unit 2613	Page 6 of 6

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,446,298 B1	11-2008	Stone, Thomas W.	250/216
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.